

UNISONIC TECHNOLOGIES CO., LTD

UTML6401

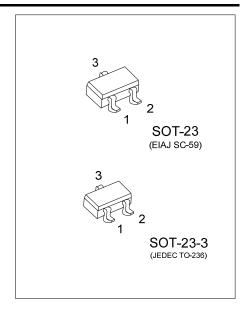
Preliminary

Power MOSFET

-4.5A, -12V P-CHANNEL POWER MOSFET

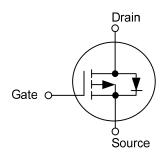
■ DESCRIPTION

The UTC **UTML6401** is a P-channel enhancement power MOSFET using UTC's advanced technology to provide the customers with perfect $R_{\text{DS(ON)}}$ and low gate charge from utilize advanced processing techniques to achieve extremely low on-resistance per silicon area, combined with the fast switching speed and ruggedized device design power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in battery and load management, the thermal resistance and power dissipation are the best available.



■ FEATURES

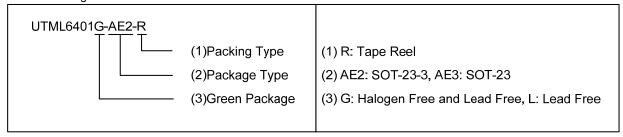
■ SYMBOL



ORDERING INFORMATION

Ordering Number		Daalaasa	Pin Assignment			Dankina	
Lead Free	Halogen Free	Package	1	2	3	Packing	
UTML6401L-AE2-R	UTML6401G-AE2-R	SOT-23-3	G	S	D	Tape Reel	
UTML6401L-AE3-R	UTML6401G-AE3-R	SOT-23	G	S	D	Tape Reel	

Note: Pin Assignment: G: Gate S: Source D: Drain

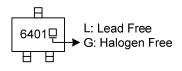


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^{*} $R_{DS(ON)} \le 58 \text{ m}\Omega$ @ V_{GS} = -4.5V, I_D = -4.3A $R_{DS(ON)} \le 85 \text{ m}\Omega$ @ V_{GS} = -2.5V, I_D = -2.5A $R_{DS(ON)} \le 145 \text{ m}\Omega$ @ V_{GS} = -1.8V, I_D = -2.0A

^{*} Ultra Low On-Resistance

■ MARKING



■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		$V_{ t DSS}$	-12	V
Gate-Source Voltage		V_{GSS}	±8	V
Continuous Drain Current	Continuous	I _D	-4.5	Α
Pulsed Drain Current	Pulsed (Note 2)	I _{DM}	-9.0	Α
Power Dissipation	SOT-23-3	Б	0.65	W
	SOT-23	P_{D}	0.67	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55 ~ + 150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT	
Junction to Ambient	SOT-23-3		190	°C/W	
	SOT-23	θ_{JA}	185	°C/W	

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

■ ELECTRICAL CHARACTERISTICS (T_J=25°C, unless otherwise specified)

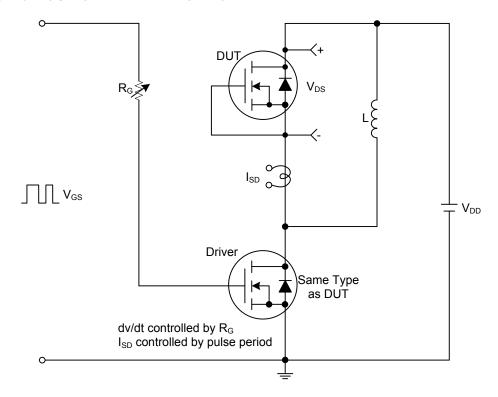
PARAMETER		SYMBOL	TEST CONDITIONS		TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV_{DSS}	V_{GS} =0 V, I_{D} =-250 μ A	-12			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =-12V, V _{GS} =0V			-1	μΑ
Fo	rward	I _{GSS}	V_{DS} =0V, V_{GS} =+8V			100	nA
Gate-Source Leakage Current Re	everse		V_{DS} =0V, V_{GS} =-8V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=-250\mu A$	-0.4		-0.95	V
			V_{GS} =-4.5V, I_{D} =-4.3A			58	mΩ
Static Drain-Source On-Resistance		R _{DS(ON)}	V _{GS} =-2.5V, I _D =-2.5A			85	mΩ
			V _{GS} =-1.8V, I _D =-2.0A			145	mΩ
DYNAMIC PARAMETERS							
Input Capacitance		C_{ISS}			810		pF
Output Capacitance		Coss	V _{DS} =-6V, V _{GS} =0V, f=1.0MHz		292		pF
Reverse Transfer Capacitance		C_{RSS}			245		pF
SWITCHING PARAMETERS							
Total Gate Charge (Note 1)		Q_G	\(- C\\ \\ - 4.5\\ \ \ - 4.5\		9		nC
Gate Source Charge		Q_GS	V_{DS} =-6V, V_{GS} =-4.5V, I_{D} =-4.5A		1.2		nC
Gate Drain Charge		Q_GD	(Note 1, 2)		2.4		nC
Turn-ON Delay Time (Note 1)		$t_{D(ON)}$			8		ns
Turn-ON Rise Time		t_R	V_{DD} =-6V, V_{GS} =-4.5V, I_{D} =-4.5A,		17		ns
Turn-OFF Delay Time		t _{D(OFF)}	R _G =3Ω (Note 1, 2)		30		ns
Turn-OFF Fall-Time		t _F			29		ns
SOURCE- DRAIN DIODE RATINGS	S AND CH	HARACTERIS	STICS				
Maximum Body-Diode Continuous Current		Is				-4.5	Α
Maximum Pulsed Drain-Source Diode		I _{SM}				0.0	۸
Forward Current						-9.0	Α
Diode Forward Voltage (Note 1)		V_{SD}	I _S =-4.5A, V _{GS} =0V			1.4	V

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle≤2%.

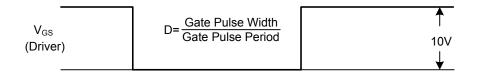
^{2.} Repetitive Rating: Pulse width limited by maximum junction temperature.

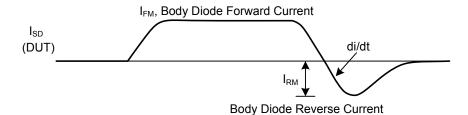
^{2.} Essentially independent of operating temperature.

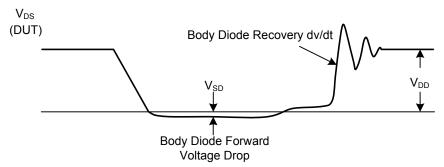
■ TEST CIRCUITS AND WAVEFORMS



Peak Diode Recovery dv/dt Test Circuit



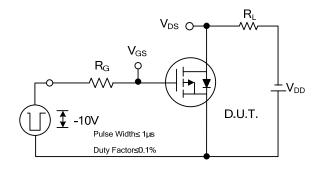


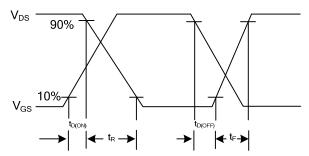


Peak Diode Recovery dv/dt Test Circuit and Waveforms

Peak Diode Recovery dv/dt Waveforms

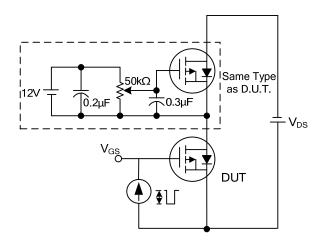
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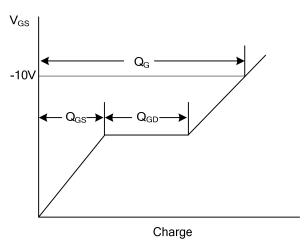




Switching Test Circuit

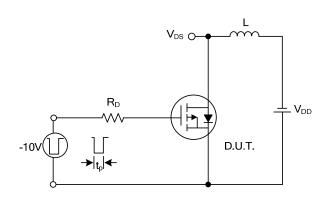
Switching Waveforms

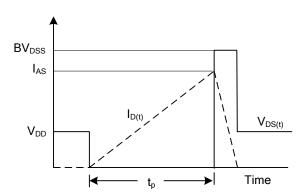




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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